Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/710,341	TAKAHASHI ET AL.	
Examiner	Art Unit	
Tran N. Nguyen	2834	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

DATE

EXMR

SEARCHED						
Class	Subclass	Date	Examiner			
310	90	4/22/05	Jan			
417	423.1	4/0,1				
	423.3	124/	7			
	423.5 423.7	105	/ pm			
	423.7		<u> </u>			
	423.12					
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INTERFERENCE SEARCHED

Date

Examiner

Subclass

Class

310